Notice of References Cited

Application/Control No. 10/650,894	Applicant(s)/Pate Reexamination MCGEE ET AL.	•		
Examiner	Art Unit			
Bryan P. Bui	2109	Page 1 of 1		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0093420 A1	05-2003	Ramme, Kay P. 707/3	
*	В	US-2004/0255293 A1	12-2004	Spotswood, Mark	717/176
*	С	US-2004/0255233 A1	12-2004	Croney et al.	715/500
*	D	US-6,370,549 B1	04-2002	Saxton, Thomas W.	707/205
*	E	US-7,185,342 B1	02-2007	Carrer et al.	719/313
*	Ľ.	US-2004/0172618 A1	09-2004	Marvin, Kyle 717/	
*	G	US-2004/0122912 A1	06-2004	Kim et al. 709/2	
*	Н	US-2003/0191826 A1	10-2003	Bellinger et al. 709	
*	1	US-2004/0205564 A1	10-2004	Brayton et al. 715/51	
*	J	US-2004/0054793 A1	03-2004	Coleman, Richard	709/229
*	K	US-2003/0229888 A1	12-2003	Spotswood et al.	717/116
	L	US-			
	М	US-			·

FOREIGN PATENT DOCUMENTS

*	:	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	P					
	Q					
	R					
	S	•				
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	w					
	×					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.